

PCTEST ENGINEERING LABORATORY, INC.

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MEASUREMENT REPORT

FCC Part 22 & 90

Applicant Name:

Samsung Electronics Co., Ltd. 129, Samsung-ro, Yeongtong-gu, Suwon-si Gyeonggi-do, 16677, Korea Date of Testing: 9/26-10/26/2017 Test Site/Location: PCTEST Lab. Columbia, MD, USA Test Report Serial No.: 1M1709250255-04.A3L

FCC ID:

APPLICANT:

A3LSMA530N

Samsung Electronics Co., Ltd.

Application Type: Model: EUT Type: FCC Classification: FCC Rule Part: Test Procedure(s): Certification SM-A530N Portable Handset PCS Licensed Transmitter Held to Ear (PCE) §2.1049, §22(H), §90.691 ANSI C63.26-2015, ANSI/TIA-603-E-2016, KDB 971168 D01 v03

This equipment has been shown to be capable of compliance with the applicable technical standards as indicated in the measurement report and was tested in accordance with the measurement procedures specified in §2.947. Test results reported herein relate only to the item(s) tested.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.





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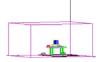


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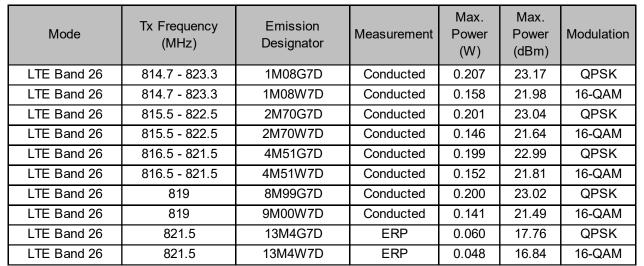
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EUT Overview

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1.0 INTRODUCTION

1.1 Scope

Measurement and determination of electromagnetic emissions (EMC) of radio frequency devices including intentional and/or unintentional radiators for compliance with the technical rules and regulations of the Federal Communications Commission and the Innovation, Science and Economic Development Canada.

1.2 PCTEST Test Location

These measurement tests were conducted at the PCTEST Engineering Laboratory, Inc. facility located at 7185 Oakland Mills Road, Columbia, MD 21046. The facility is 0.4 miles North of the FCC laboratory, and the ambient signal and ambient signal strength are approximately equal to those of the FCC laboratory. The measurement facility is compliant with the test site requirements specified in ANSI C63.4-2014.

1.3 Test Facility / Accreditations

Measurements were performed at PCTEST Engineering Lab located in Columbia, MD 21046, U.S.A.

- PCTEST is an ISO 17025-2005 accredited test facility under the American Association for Laboratory Accreditation (A2LA) with Certificate number 2041.01 for Specific Absorption Rate (SAR), Hearing Aid Compatibility (HAC) testing, where applicable, and Electromagnetic Compatibility (EMC) testing for FCC and Innovation, Science, and Economic Development Canada rules.
- PCTEST TCB is a Telecommunication Certification Body (TCB) accredited to ISO/IEC 17065-2012 by A2LA (Certificate number 2041.03) in all scopes of FCC Rules and ISED Standards (RSS).
- PCTEST facility is a registered (22831) test laboratory with the site description on file with ISED.

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2.0 PRODUCT INFORMATION

2.1 Equipment Description

The Equipment Under Test (EUT) is the **Samsung Portable Handset FCC ID: A3LSMA530N**. The test data contained in this report pertains only to the emissions due to the EUT's licensed transmitters that operate under the provisions of Part 22(H) and 90.691.

Test Device Serial No.: 18728, 18736, 18785

2.2 Device Capabilities

This device contains the following capabilities:

1900 GSM/GPRS/EDGE, 850/1900 WCDMA/HSPA, Multi-band LTE, 802.11b/g/n WLAN, 802.11a/n/ac UNII, Bluetooth (1x, EDR, LE), NFC, ANT+

2.3 Test Configuration

The EUT was tested per the guidance of ANSI/TIA-603-E-2016 and KDB 971168 D01 v03. See Section 7.0 of this test report for a description of the radiated and antenna port conducted emissions tests.

2.4 EMI Suppression Device(s)/Modifications

No EMI suppression device(s) were added and no modifications were made during testing.

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3.0 DESCRIPTION OF TESTS

3.1 Evaluation Procedure

The measurement procedures described in the document titled "Land Mobile FM or PM – Communications Equipment – Measurements and Performance Standards" (ANSI/TIA-603-E-2016) and "Procedures for Compliance Measurement of the Fundamental Emission Power of Licensed Wideband (> 1 MHz) Digital Transmission Systems" (KDB 971168 D01 v03) were used in the measurement of the EUT.

3.2 Radiated Power and Radiated Spurious Emissions

<u>§2.1053, §90.635, §90.691</u>

The radiated test facilities consisted of an indoor 3 meter semi-anechoic chamber used for final measurements and exploratory measurements, when necessary. The measurement area is contained within the semi-anechoic chamber which is shielded from any ambient interference. The test site inside the chamber is a 6m x 5.2m elliptical, obstruction-free area in accordance with Figure 5.7 of Clause 5 in ANSI C63.4-2014. Absorbers are arranged on the floor between the turn table and the antenna mast in such a way so as to maximize the reduction of reflections for measurements above 1GHz. For measurements below 1GHz, the absorbers are removed. A raised turntable is used for radiated measurement. The turn table is a continuously rotatable, remote-controlled, metallic turntable and 2 meters (6.56 ft.) in diameter. The turn table is flush with the raised floor of the chamber in order to maintain its function as a ground plane. An 80cm high Styrodur Plastic Test Table is placed on top of the turntable. For measurements above 1GHz, an additional Styrodur pedestal is placed on top of the test table to bring the total table height to 1.5m.

The equipment under test was transmitting while connected to its integral antenna and is placed on a wooden turntable 80cm above the ground plane and 3 meters from the receive antenna. The receive antenna height is adjusted between 1 and 4 meter height, the turntable is rotated through 360 degrees, and the EUT is manipulated through all orthogonal planes representative of its typical use to achieve the highest reading on the receive spectrum analyzer. Radiated power levels are also investigated with the receive antenna horizontally and vertically polarized. The maximized power level is recorded using the spectrum analyzer "Channel Power" function with the integration band set to the emissions' occupied bandwidth, a RMS detector, RBW = 100kHz, VBW = 300kHz, and a 1 second sweep time over a minimum of 10 sweeps, per the guidelines of KDB 971168 D01 v03.

Per the guidance of ANSI/TIA-603-E-2016, a half-wave dipole is then substituted in place of the EUT. For emissions above 1GHz, a horn antenna is substituted in place of the EUT. The substitute antenna is driven by a signal generator with the level of the signal generator being adjusted to obtain the same receive spectrum analyzer level previously recorded from the spurious emission from the EUT. The power of the emission is calculated using the following formula:

$$P_{d [dBm]} = P_{g [dBm]} - cable loss [dB] + antenna gain [dBd/dBi]$$

Where, P_d is the dipole equivalent power, P_g is the generator output into the substitution antenna, and the antenna gain is the gain of the substitute antenna used relative to either a half-wave dipole (dBd) or an isotropic source (dBi). The substitute level is equal to $P_{g [dBm]}$ – cable loss [dB].

The calculated Pd levels are then compared to the absolute spurious emission limit of -13dBm which is equivalent to the required minimum attenuation of 43 + 10log₁₀(Power [Watts]) specified in 90.691.

For fundamental radiated power measurements, the guidance of KDB 971168 D01 v03 is used to record the EUT power level that is subsequently matched via the aforementioned substitution method given in ANSI/TIA-603-E-2016.

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4.0 MEASUREMENT UNCERTAINTY

The measurement uncertainties shown below were calculated in accordance with the requirements of ANSI C63.4-2014. All measurement uncertainty values are shown with a coverage factor of k = 2 to indicate a 95% level of confidence. The measurement uncertainty shown below meets or exceeds the U_{CISPR} measurement uncertainty values specified in CISPR 16-4-2 and, thus, can be compared directly to specified limits to determine compliance.

Contribution	Expanded Uncertainty (±dB)
Conducted Bench Top Measurements	1.13
Radiated Disturbance (<1GHz)	4.98
Radiated Disturbance (>1GHz)	5.07
Radiated Disturbance (>18GHz)	5.09

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5.0 TEST EQUIPMENT CALIBRATION DATA

Test Equipment Calibration is traceable to the National Institute of Standards and Technology (NIST). Measurements antennas used during testing were calibrated in accordance to the requirements of ANSI C63.5-2017.

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
-	LTx1	Licensed Transmitter Cable Set	1/6/2017	Annual	1/6/2018	LTx1
-	RE1	Radiated Emissions Cable Set (UHF/EHF)	6/21/2017	Annual	6/21/2018	RE1
Agilent	E5515C	Wireless Communications Test Set	1/29/2016	Biennial	1/29/2018	GB46310798
Agilent	N9020A	MXA Signal Analyzer	10/28/2016	Annual	10/28/2017	US46470561
Agilent	N9030A	PXA Signal Analyzer (44GHz)	3/27/2017	Annual	3/27/2018	MY52350166
COM-Power	AL-130R	Active Loop Antenna	6/5/2017	Annual	6/5/2018	121085
Com-Power	PAM-103	Pre-Amplifier (1-1000MHz)	6/21/2017	Annual	6/21/2018	441119
Emco	3115	Horn Antenna (1-18GHz)	3/10/2016	Biennial	3/10/2018	9704-5182
EMCO	3160-09	Small Horn (18 - 26.5GHz)	8/23/2016	Biennial	8/23/2018	135427
Espec	ESX-2CA	Environmental Chamber	4/11/2017	Annual	4/11/2018	17620
ETS Lindgren	3117	1-18 GHz DRG Horn (Medium)	12/1/2016	Biennial	12/1/2018	125518
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	4/26/2016	Biennial	4/26/2018	128337
ETS Lindgren	3164-08	Quad Ridge Horn Antenna	12/5/2016	Biennial	12/5/2018	128338
Mini Circuits	PWR-SEN-4GHS	USB Power Sensor	3/24/2017	Annual	3/24/2018	11401010036
Mini Circuits	TVA-11-422	RF Power Amp		N/A		QA1317001
Mini-Circuits	PWR-SEN-4RMS	USB Power Sensor	3/24/2017	Annual	3/24/2018	11210140001
Mini-Circuits	SSG-4000HP	Synthesized Signal Generator		N/A		11208010032
PCTEST	-	EMC Switch System	6/21/2017	Annual	6/21/2018	NM1
PCTEST	-	EMC Switch System	6/21/2017	Annual	6/21/2018	NM2
Rohde & Schwarz	CMW500	Radio Communication Tester	11/20/2016	Annual	11/20/2017	100976
Rohde & Schwarz	ESU26	EMI Test Receiver (26.5GHz)	4/19/2017	Annual	4/19/2018	100342
Rohde & Schwarz	ESU40	EMI Test Receiver (40GHz)	7/31/2017	Annual	7/31/2018	100348
Rohde & Schwarz	TS-PR26	18-26.5 GHz Pre-Amplifier	5/11/2017	Annual	5/11/2018	100040
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Rx	3/30/2016	Biennial	3/30/2018	9105-2404
Schwarzbeck	UHA 9105	Dipole Antenna (400 - 1GHz) Tx	3/30/2016	Biennial	3/30/2018	9105-2403
Seekonk	NC-100	Torque Wrench 5/16", 8" lbs	3/2/2016	Biennial	3/2/2018	N/A
Sunol	DRH-118	Horn Antenna (1-18GHz)	8/11/2017	Biennial	8/11/2019	A050307
Sunol	JB5	Bi-Log Antenna (30M - 5GHz)	3/14/2016	Biennial	3/14/2018	A051107

Table 5-1. Test Equipment

Notes:

- 1. For equipment listed above that has a calibration date or calibration due date that falls within the test date range, care was taken to ensure that this equipment was used after the calibration date and before the calibration due date.
- 2. Equipment with a calibration date of "N/A" shown in this list was not used to make direct calibrated measurements.

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6.0 SAMPLE CALCULATIONS

Emission Designator

QPSK Modulation

Emission Designator = 8M62G7D

LTE BW = 8.62 MHz

- G = Phase Modulation
- 7 = Quantized/Digital Info
- D = Data transmission, telemetry, telecommand

16QAM Modulation

Emission Designator = 8M45W7D

LTE BW = 8.45 MHz W = Amplitude/Angle Modulated 7 = Quantized/Digital Info D = Data transmission, telemetry, telecommand

Spurious Radiated Emission – LTE Band

Example: Middle Channel LTE Mode 2nd Harmonic (1564 MHz)

The average spectrum analyzer reading at 3 meters with the EUT on the turntable was -81.0 dBm. The gain of the substituted antenna is 8.1 dBi. The signal generator connected to the substituted antenna terminals is adjusted to produce a reading of -81.0 dBm on the spectrum analzyer. The loss of the cable between the signal generator and the terminals of the substituted antenna is 2.0 dB at 1564 MHz. So 6.1 dB is added to the signal generator reading of -30.9 dBm yielding -24.80 dBm. The fundamental EIRP was 25.501 dBm so this harmonic was 25.501 dBm – (-24.80).

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7.0 TEST RESULTS

7.1 Summary

Company Name:	Samsung Electronics Co., Ltd.
FCC ID:	A3LSMA530N
FCC Classification:	PCS Licensed Transmitter Held to Ear (PCE)
Mode(s):	LTE
Band:	Band 26

FCC Part Section(s)	Test Description	Test Limit	Test Condition	Test Result	Reference
2.1049	Occupied Bandwidth	N/A		PASS	Section 7.2
2.1051 90.691	Conducted Band Edge / Spurious Emissions	 > 43 + log₁₀ (P[Watts]) for all out- of-band emissions except > 50 + 10log₁₀ (P[Watts]) at Band Edge and for all out-of- band emissions within 37.5kHz of Block Edge 	CONDUCTED	PASS	Sections 7.3, 7.4
2.1055 90.213	Frequency Stability	< 2.5 ppm		PASS	Section 7.8
2.1046 90.635	Conducted Power	< 100 Watts		PASS	Section 7.5
22.913(a.2)	Effective Radiated Power (Band 26)	< 7 Watts max. ERP		PASS	Section 7.6
2.1053 90.691	Radiated Spurious Emissions	 > 43 + log₁₀ (P[Watts]) for all out- of-band emissions except > 50 + 10log₁₀ (P[Watts]) at Band Edge and for all out-of- band emissions within 37.5kHz of Block Edge 	RADIATED	PASS	Section 7.7

Table 7-1. Summary of Test Results

Notes:

- 1) All modes of operation and data rates were investigated. The test results shown in the following sections represent the worst case emissions.
- 2) The analyzer plots shown in Section 7.0 were taken with a correction table loaded into the analyzer. The correction table was used to account for the losses of the cables, directional couplers, and attenuators used as part of the system to maintain a link between the call box and the EUT at all frequencies of interest.
- 3) All antenna port conducted emissions testing was performed on a test bench with the antenna port of the EUT connected to the spectrum analyzer through calibrated cables, attenuators, and couplers.
- 4) For conducted spurious emissions, automated test software was used to measure emissions and capture the corresponding plots necessary to show compliance. The measurement software utilized is PCTEST "2G/3G Automation," Version 3.9.

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7.2 Occupied Bandwidth §2.1049

Test Overview

The occupied bandwidth, that is the frequency bandwidth such that, below its lower and above its upper frequency limits, the mean powers radiated are each equal to 0.5 percent of the total mean power radiated by a given emission shall be measured. All modes of operation were investigated and the worst case configuration results are reported in this section.

Test Procedure Used

KDB 971168 D01 v03 - Section 4.2

Test Settings

- 1. The signal analyzer's automatic bandwidth measurement capability was used to perform the 99% occupied bandwidth and the 26dB bandwidth. The bandwidth measurement was not influenced by any intermediate power nulls in the fundamental emission.
- 2. RBW = 1 5% of the expected OBW
- 3. VBW \geq 3 x RBW
- 4. Detector = Peak
- 5. Trace mode = max hold
- 6. Sweep = auto couple
- 7. The trace was allowed to stabilize
- 8. If necessary, steps 2 7 were repeated after changing the RBW such that it would be within

1-5% of the 99% occupied bandwidth observed in Step 7

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

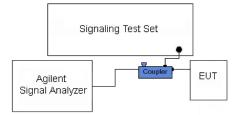


Figure 7-1. Test Instrument & Measurement Setup

Test Notes

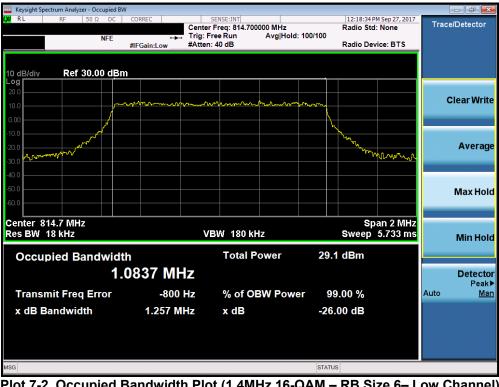
None.

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Plot 7-1. Occupied Bandwidth Plot (1.4MHz QPSK - RB Size 6- Low Channel)



Plot 7-2. Occupied Bandwidth Plot (1.4MHz 16-QAM – RB Size 6– Low Channel)

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Keysight Spectrum Analys													×
KAN RL RF	50 Ω	DC	CORREC			INSE:INT Freg: 815.500	000 MHz		F	12:12:54	M Sep 27, 2017	Trac	e/Detector
	N	FE			Talas Da	e Run	Avg Hold	: 100/100			Jan DTC		
			#IFGain:	Low	#Atten:	40 dB				kadio De	vice: BTS		
10 dB/div Ref	30.00	dBm					1				1		
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-40.0													
-50.0													Max Hold
-60.0													
Center 815.5 MH Res BW 47 kHz	Z				VB	W 470 L	1				an 5 MHz		
Res BW 47 KHZ					VB	W 470 ki	12			sweep	2.533 ms		Min Hold
Occupied B	andv	vidt	h			Total P	ower	3	0.2 c	lBm			
			7012		7								Detector
		2.			12								Peak
Transmit Free	q Erro	r	-3.	.453 k	Hz	% of O	BW Powe	er	99.0	0 %		Auto	Mar
x dB Bandwid	dth		3.	050 M	Hz	x dB		-2	26.00) dB			
MSG								ST	ATUS				

Plot 7-3. Occupied Bandwidth Plot (3MHz QPSK - RB Size 15- Low Channel)



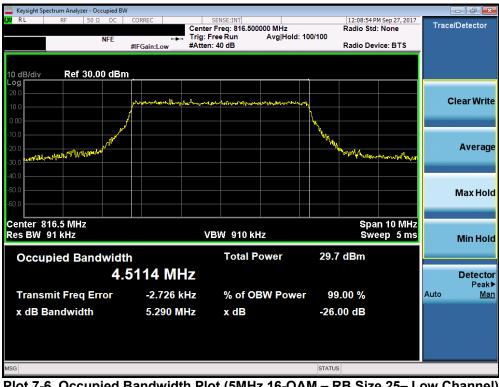
Plot 7-4. Occupied Bandwidth Plot (3MHz 16-QAM – RB Size 15– Low Channel)

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Plot 7-5. Occupied Bandwidth Plot (5MHz QPSK - RB Size 25- Low Channel)



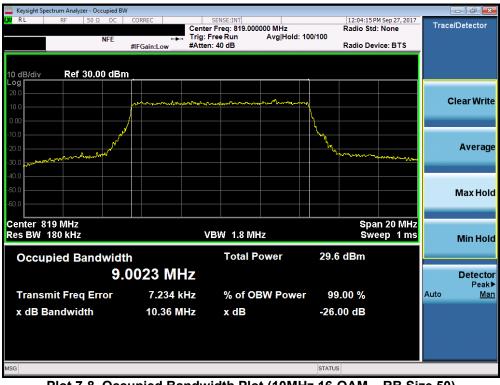
Plot 7-6. Occupied Bandwidth Plot (5MHz 16-QAM – RB Size 25– Low Channel)

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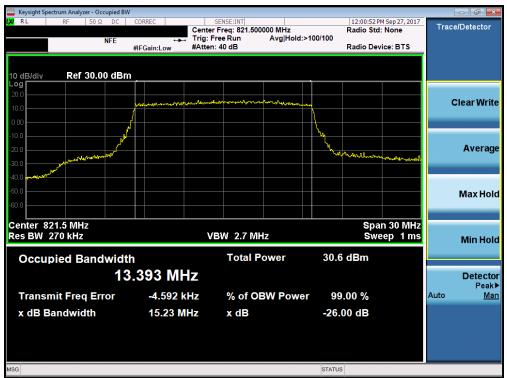
Plot 7-7. Occupied Bandwidth Plot (10MHz QPSK - RB Size 50)



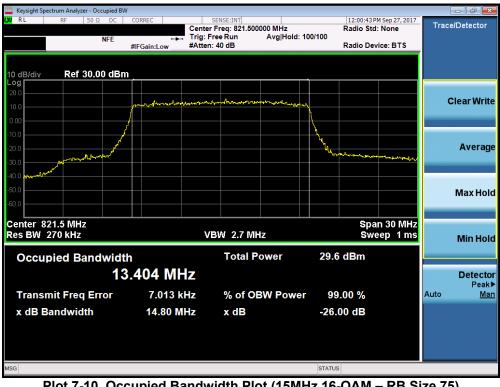
Plot 7-8. Occupied Bandwidth Plot (10MHz 16-QAM - RB Size 50)

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Plot 7-9. Occupied Bandwidth Plot (15MHz QPSK - RB Size 75)



Plot 7-10. Occupied Bandwidth Plot (15MHz 16-QAM – RB Size 75)

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7.3 Spurious and Harmonic Emissions at Antenna Terminal §2.1051 §90.691

Test Overview

The level of the carrier and the various conducted spurious and harmonic frequencies is measured by means of a calibrated spectrum analyzer. The spectrum is scanned from the lowest frequency generated in the equipment up to a frequency including its 10th harmonic. All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission is $43 + \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03 - Section 6.0

Test Settings

- 1. Start frequency was set to 30MHz and stop frequency was set to 10GHz (separated into at least two plots per channel)
- 2. RBW ≥ 1MHz
- 3. VBW \geq 3 x RBW
- 4. Detector = RMS
- 5. Trace mode = max hold
- 6. Sweep time = auto couple
- 7. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

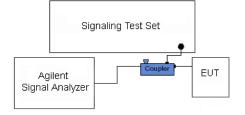


Figure 7-2. Test Instrument & Measurement Setup

Test Notes

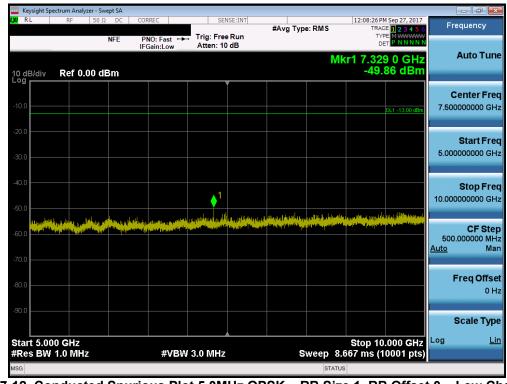
Compliance with the applicable limits is based on the use of measurement instrumentation employing a resolution bandwidth of 100 kHz or greater for Part 22. However, in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

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	ectrum Analyz											7 ×
LX/ RL	RF	50 Ω DO	C CORF	EC	SEN	ISE:INT	#Avg Typ	e: RMS		M Sep 27, 2017	Frequen	су
		NFE	PN	0:Fast ↔ ain:Low	Trig: Free Atten: 40				T			
								Mki	1 3.793	284 GHz .68 dBm	Auto	Tune
10 dB/div Log	Ref 30.	.00 dBn	n						-22	.68 aBm		
											Center	r Freq
20.0											2.51500000	0 GHz
10.0												
10.0											Start	Freq
0.00											30.00000	0 MHz
-10.0										DL1 -13.00 dBm	Stop	Freq
-20.0								1			5.0000000	0 GHz
								. Labor	haan <mark>alan</mark> ka sakaka	المقاربين فأبلوهم بقير		
-30.0			أمري بر فلال و	فالمتغال والالا							CF 497.00000	Step
(despects		Contraction of the second	and a supply of	and a standard state	and the second second						Auto	Man
-40.0 11114 - 81 11												
-50.0											FreqC	Offset
-30.0												0 Hz
-60.0												
											Scale	Туре
Start 30 I	MHz								Stop	5.000 GHz	Log	Lin
#Res BW				#VBW	3.0 MHz		s	weep	8.667 ms (10001 pts)		
MSG								STAT	rus			

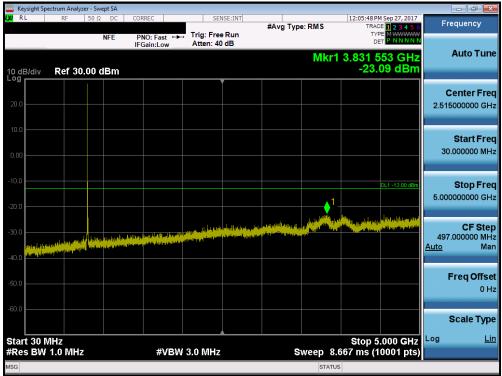
Plot 7-11. Conducted Spurious Plot (5.0MHz QPSK - RB Size 1, RB Offset 0 - Low Channel)



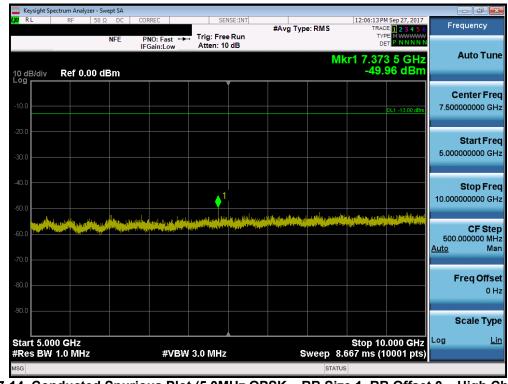
Plot 7-12. Conducted Spurious Plot 5.0MHz QPSK – RB Size 1, RB Offset 0 – Low Channel)

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Plot 7-13. Conducted Spurious Plot (5.0MHz QPSK - RB Size 1, RB Offset 0 - High Channel)



Plot 7-14. Conducted Spurious Plot (5.0MHz QPSK – RB Size 1, RB Offset 0 – High Channel)

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7.4 Band Edge Emissions at Antenna Terminal §2.1051 §90.691

Test Overview

All out of band emissions are measured with a spectrum analyzer connected to the antenna terminal of the EUT while the EUT is operating at maximum power, and at the appropriate frequencies. All data rates were investigated to determine the worst case configuration. All modes of operation were investigated and the worst case configuration results are reported in this section.

The minimum permissible attenuation level of any spurious emission removed from the EA licensee's frequency block by greater than 37.5 kHz is $43 + \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

The minimum permissible attenuation level of any spurious emission removed from the EA licensee's frequency block by up to and including 37.5 kHz is $50 + 10 \log_{10}(P_{[Watts]})$, where P is the transmitter power in Watts.

Test Procedure Used

KDB 971168 D01 v03 – Section 6.0

Test Settings

- 1. Span was set large enough so as to capture all out of band emissions near the band edge
- 2. RBW = 100 kHz
- 3. VBW = 300 kHz
- 4. Detector = RMS
- 5. Trace mode = trace average
- 6. Sweep time = auto couple
- 7. The trace was allowed to stabilize

Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

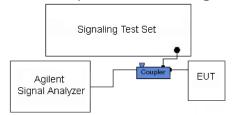


Figure 7-3. Test Instrument & Measurement Setup

Test Notes

For channel edge emission, the signal analyzer's "ACP" measurement capability is used.

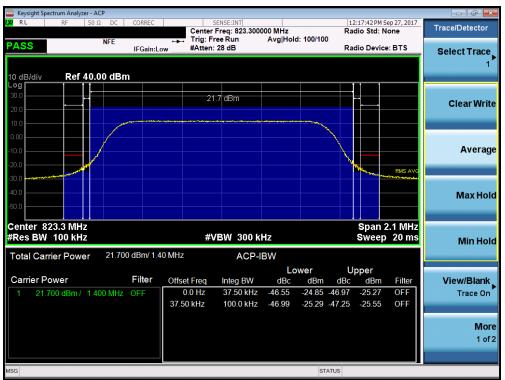
Per 22.917(b) in the 1 MHz bands immediately outside and adjacent to the frequency block a resolution bandwidth of at least one percent of the emission bandwidth of the fundamental emission of the transmitter may be employed to demonstrate compliance with the out-of-band emissions limit. The emission bandwidth is defined as the width of the signal between two points, one below the carrier center frequency and one above the carrier center frequency, outside of which all emission are attenuated at least 26 dB below the transmitter power.

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Keysight Spectrum Analyzer - ACP RL RF 50 Ω DC CORREC ASS NFE IFGain:L	Center Trig: Fr		000 MHz Avg Hold:	100/100	12:20:06 PM S Radio Std: N Radio Devic	lone	Trace/Detector
0 dB/div Ref 40.00 dBm	ow #Atten.	20 0.0			Radio Devic	e. B13	Select Trace 1
	22	.0 dBm					Clear Writ
						RMS AVG	Averag
							Max Ho
enter 814.7 MHz Res BW 100 kHz		/BW 300 ki				2.1 MHz) 20 ms	Min Ho
otal Carrier Power 21.968 dBm/ 1.4	40 MHz	ACP-I	BW Low		Upper		
Carrier Power Filter	Offset Freq	Integ BW	dBc		Bc dBm	Filter	View/Blank
1 21.968 dBm / 1.400 MHz OFF	0.0 Hz 37.50 kHz	37.50 kHz 100.0 kHz		-24.15 -47. -24.56 -47.		OFF OFF	Trace Or
							Мо 1 о
9				STATUS			

Plot 7-15. Channel Edge Plot (1.4MHz QPSK – RB Size 6– Low Channel)



Plot 7-16. Channel Edge Plot (1.4MHz QPSK – RB Size 6 – High Channel)

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Keysight Spectrum Analyzer - ACP I RF 50 Ω DC CORREC ASS NFE IFGain: IFGain:	Center I		000 MHz Avg Hold:	100/100	Rad	:14:31 PM lio Std: I lio Devic		Trace/Detector
10 dB/div Ref 40.00 dBm								1
	22	.0 dBm						Clear Write
							RMS AVG	Averag
								Max Hol
Center 815.5 MHz Res BW 100 kHz		'BW 300 ki					n 4 MHz o 20 ms	Min Hol
Total Carrier Power 22.003 dBm/ 3		ACP-I	BVV Low	er	Ur	oper		
Carrier Power Filter	Offset Freq	Integ BW	dBc	dBm	dBc	dBm	Filter	View/Blank
1 22.003 dBm / 3.000 MHz OFF	0.0 Hz 37.50 kHz	37.50 kHz 100.0 kHz		-24.55 -24.00	-46.52 -46.38	-24.51 -24.38	OFF OFF	Trace On
								Moi 1 of
G				ST/	ATUS			

Plot 7-17. Channel Edge Plot (3MHz QPSK – RB Size 15– Low Channel)



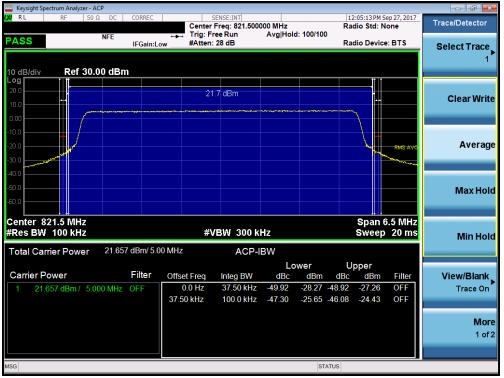
Plot 7-18. Channel Edge Plot (3MHz QPSK – RB Size 15 – High Channel)

FCC ID: A3LSMA530N		MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager	
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Keysight Spectrum Analyzer - ACP								
<mark>LX/</mark> RL RF 50Ω	DC CORREC		SENSE:INT Freq: 816.500	000 MHz	F	12:07:28 PM 9		Trace/Detector
PASS	NFE	Trig: Fr	ree Run	Avg Hold	: 100/100			
PA55	IFGain:	Low #Atten:	28 dB		F	Radio Devic	e: BTS	Select Trace
								1
10 dB/div Ref 30.00	dBm		_					
20.0								
10.0		22	.0 dBm					Clear Write
·····					~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~~	\sim		
0.00								
-10.0								
-20.0						~~~~	RMS AVG	Average
-30.0							Marker Conner	
-40.0								
-50.0								Max Hold
-60.0								Maxiton
Center 816.5 MHz							6.5 MHz	
#Res BW 100 kHz		#\	/BW 300 k	HZ		Sweep) 20 ms	Min Hold
Total Carrier Power	22.011 dBm/ 5	.00 MHz	ACP-I	BW				
				Lo	wer	Upper		
Carrier Power	Filter	Offset Freq	Integ BW	dBc	dBm dB		Filter	View/Blank
1 22.011 dBm / 5.000	MHz OFF	0.0 Hz	37.50 kHz	-49.18	-27.17 -49.2		OFF	Trace On
		37.50 kHz	100.0 kHz	-46.41	-24.40 -46.3	5 -24.35	OFF	
								More
								1 of 2
MSG					STATUS			

Plot 7-19. Channel Edge Plot (5MHz QPSK – RB Size 25– Low Channel)



Plot 7-20. Channel Edge Plot (5MHz QPSK – RB Size 25 – High Channel)

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Keysight Spectrum Analyzer - ACP							
RL RF 50Ω DC CORI	Center	SENSE:INT Freq: 819.0000 ree Run 28 dB	000 MHz Avg Hold: 100/1	Ra 00	dio Std: N	one	Trace/Detector
0 dB/div Ref 30.00 dBm	an.cow and a						Select Trace
	21	.7 dBm					Clear Write
10.0 20.0 30.0					- L	RMS AVG	Average
40.0 50.0 50.0 50.0							Max Hold
Center 819 MHz Res BW 100 kHz		/BW 300 k				12 MHz 20 ms	Min Hol
Total Carrier Power 21.749 dBn	√ 10.00 MHz	ACP-I					
Carrier Power Filt	er Offset Freg	Integ BW	Lower dBc dBr		pper dBm	Filter	View/Blank
1 21.749 dBm / 10.00 MHz OFF	onserried	37.50 kHz 100.0 kHz	-55.13 -33.3		-33.02	OFF OFF	Trace On
							Mor 1 of
SG				STATUS			

Plot 7-21. Channel Edge Plot (10MHz QPSK – RB Size 50)



Plot 7-22. Channel Edge Plot (15MHz QPSK – RB Size 75)

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7.5 Conducted Power Output Data §90.635

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Cond. PWR [dBm]	Cond. PWR [Watts]	Cond. PWR Limit [dBm]	Margin [dB]
814.70	1.4	QPSK	23.17	0.207	50.00	-26.83
823.30	1.4	QPSK	22.85	0.193	50.00	-27.15
814.70	1.4	16-QAM	21.98	0.158	50.00	-28.02
823.30	1.4	16-QAM	21.38	0.137	50.00	-28.62
815.50	3	QPSK	23.04	0.201	50.00	-26.96
822.50	3	QPSK	22.85	0.193	50.00	-27.15
815.50	3	16-QAM	21.64	0.146	50.00	-28.36
822.50	3	16-QAM	21.58	0.144	50.00	-28.42
816.50	5	QPSK	22.99	0.199	50.00	-27.01
821.50	5	QPSK	22.90	0.195	50.00	-27.10
816.50	5	16-QAM	21.81	0.152	50.00	-28.19
821.50	5	16-QAM	21.26	0.134	50.00	-28.74
819.00	10	QPSK	23.02	0.200	50.00	-26.98
819.00	10	16-QAM	21.49	0.141	50.00	-28.51
821.50	15	QPSK	23.16	0.207	50.00	-26.84
821.50	15	16-QAM	22.01	0.159	50.00	-27.99

Table 7-2. LTE Band 26 Conducted Power Output Data

NOTES:

- 1. For LTE mode, the device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported with 1 RB.
- 2. This unit was tested with its standard battery.

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7.6 Radiated Power (ERP) §22.913(a.2)

Test Overview

Effective Radiated Power (ERP) measurements are performed using the substitution method described in ANSI/TIA-603-E-2016 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using vertically and horizontally polarized tuned dipole antennas. All measurements are performed as RMS average measurements while the EUT is operating at its maximum duty cycle, at maximum power, and at the appropriate frequencies.

Test Procedures Used

KDB 971168 D01 v03 - Section 5.2.1

ANSI/TIA-603-E-2016 - Section 2.2.17

Test Settings

- 1. Radiated power measurements are performed using the signal analyzer's "channel power" measurement capability for signals with continuous operation.
- 2. RBW = 1 5% of the expected OBW, not to exceed 1MHz
- 3. VBW \ge 3 x RBW
- 4. Span = 1.5 times the OBW
- 5. No. of sweep points \geq 2 x span / RBW
- 6. Detector = RMS
- 7. Trigger is set to "free run" for signals with continuous operation with the sweep times set to "auto".
- 8. The integration bandwidth was roughly set equal to the measured OBW of the signal for signals with continuous operation.
- 9. Trace mode = trace averaging (RMS) over 100 sweeps
- 10. The trace was allowed to stabilize

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Test Setup

The EUT and measurement equipment were set up as shown in the diagram below.

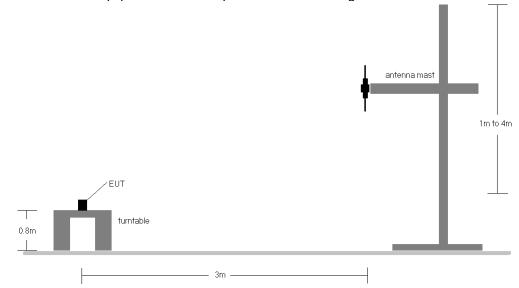


Figure 7-4. Radiated Test Setup <1GHz

Test Notes

- 1) The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case emissions are reported with the EUT positioning, modulations, RB sizes and offsets, and channel bandwidth configurations shown in the tables below.
- 2) This unit was tested with its standard battery.

Frequency [MHz]	Channel Bandwidth [MHz]	Mod.	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	RB Size/Offset	Substitute Level [dBm]	Ant. Gain [dBi]	ERP [dBm]	ERP [Watts]	ERP Limit [dBm]	Margin [dB]
821.50	15	QPSK	Н	150	328	1 / 74	18.42	1.49	17.76	0.060	38.45	-20.69
821.50	15	16-QAM	Н	150	328	1 / 74	17.50	1.49	16.84	0.048	38.45	-21.61

Table 7-3. ERP Data (Band 26)

FCC ID: A3LSMA530N		MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager	
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7.7 Radiated Spurious Emissions Measurements §2.1053 §90.691

Test Overview

Radiated spurious emissions measurements are performed using the substitution method described in ANSI/TIA-603-E-2016 with the EUT transmitting into an integral antenna. Measurements on signals operating below 1GHz are performed using horizontally and vertically polarized tuned dipole antennas. Measurements on signals operating above 1GHz are performed using vertically and horizontally polarized broadband horn antennas. All measurements are performed as peak measurements while the EUT is operating at maximum power, and at the appropriate frequencies.

Test Procedures Used

KDB 971168 D01 v03 – Section 5.8

ANSI/TIA-603-E-2016 - Section 2.2.12

Test Settings

- 1. RBW = 100kHz for emissions below 1GHz and 1MHz for emissions above 1GHz
- 2. VBW \geq 3 x RBW
- 3. Span = 1.5 times the OBW
- 4. No. of sweep points > 2 x span / RBW
- 5. Detector = RMS
- 6. Trace mode = Average (Max Hold for pulsed emissions)
- 7. The trace was allowed to stabilize

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EUT turntable & styrofoam block

The EUT and measurement equipment were set up as shown in the diagram below.

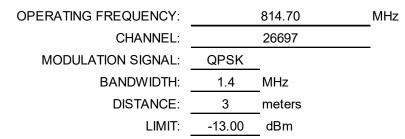
Figure 7-5. Test Instrument & Measurement Setup

Test Notes

- 1. For LTE mode, the device was tested under all modulations, RB sizes and offsets, and channel bandwidth configurations and the worst case emissions are reported with 1 RB.
- 2. This unit was tested with its standard battery.
- 3. The EUT was tested in three orthogonal planes and in all possible test configurations and positioning. The worst case setup is reported in the tables below.
- 4. The "-" shown in the following RSE tables are used to denote a noise floor measurement.

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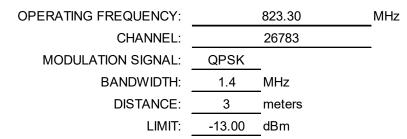


Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBd]	Spurious Emission Level [dBm]	Margin [dB]
1629.40	Н	118	178	-47.48	6.77	-40.71	-27.7
2444.10	Н	104	89	-68.42	6.96	-61.46	-48.5
3258.80	Н	100	218	-66.38	7.22	-59.16	-46.2
4073.50	Н	160	48	-64.88	7.47	-57.41	-44.4
4888.20	Н	147	68	-66.25	9.04	-57.21	-44.2
5702.90	Н	-	-	-66.54	9.15	-57.39	-44.4
6517.60	Н	204	5	-63.56	9.18	-54.38	-41.4
7332.30	Н	-	-	-60.51	8.52	-51.99	-39.0

Table 7-4. Radiated Spurious Data (Ch. 26697)

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Frequency [MHz]	Ant. Pol. [H/V]	Antenna Height [cm]	Turntable Azimuth [degree]	Level at Antenna Terminals [dBm]	Substitute Antenna Gain [dBd]	Spurious Emission Level [dBm]	Margin [dB]
1646.60	Н	118	177	-48.41	6.85	-41.56	-28.6
2469.90	Н	104	167	-67.18	6.97	-60.21	-47.2
3293.20	Н	197	101	-63.83	7.22	-56.61	-43.6
4116.50	Н	160	123	-64.14	7.66	-56.48	-43.5
4939.80	Н	141	59	-65.28	9.08	-56.20	-43.2
5763.10	Н	-	-	-66.61	9.22	-57.39	-44.4
6586.40	Н	128	336	-62.91	9.11	-53.80	-40.8
7409.70	Н	-	-	-60.04	8.64	-51.40	-38.4

Table 7-5. Radiated Spurious Data (Ch. 26783)

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7.8 Frequency Stability / Temperature Variation §2.1055 §90.213

Test Overview and Limit

Frequency stability testing is performed in accordance with the guidelines of ANSI/TIA-603-E-2016. The frequency stability of the transmitter is measured by:

- a.) **Temperature:** The temperature is varied from -30°C to +50°C in 10°C increments using an environmental chamber.
- b.) **Primary Supply Voltage:** The primary supply voltage is varied from 85% to 115% of the nominal value for non hand-carried battery and AC powered equipment. For hand-carried, battery-powered equipment, primary supply voltage is reduced to the battery operating end point which shall be specified by the manufacturer.

The frequency stability of the transmitter shall be maintained within $\pm 0.00025\%$ (± 2.5 ppm) of the center frequency.

Test Procedure Used

ANSI/TIA-603-E-2016

Test Settings

- 1. The carrier frequency of the transmitter is measured at room temperature (20°C to provide a reference).
- 2. The equipment is turned on in a "standby" condition for fifteen minutes before applying power to the transmitter. Measurement of the carrier frequency of the transmitter is made within one minute after applying power to the transmitter.
- 3. Frequency measurements are made at 10°C intervals ranging from -30°C to +50°C. A period of at least one half-hour is provided to allow stabilization of the equipment at each temperature level.

Test Setup

The EUT was connected via an RF cable to a spectrum analyzer with the EUT placed inside an environmental chamber.

Test Notes

None

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Frequency Stability / Temperature Variation §2.1055, §90.213

OPERATING FREQUENCY:	819,000,000	Hz
CHANNEL:	26740	_
REFERENCE VOLTAGE:	3.85	VDC
DEVIATION LIMIT:	± 0.00025 % or 2.5 ppm	

VOLTAGE (%)	POWER (VDC)	TEMP (°C)	FREQUENCY (Hz)	Freq. Dev. (Hz)	Deviation (%)
100 %	3.85	+ 20 (Ref)	818,999,912	-88	-0.0000107
100 %		- 30	818,999,640	-360	-0.0000440
100 %		- 20	818,999,900	-100	-0.0000122
100 %		- 10	818,999,998	-2	-0.0000002
100 %		0	818,999,992	-8	-0.0000010
100 %		+ 10	819,000,367	367	0.0000448
100 %		+ 20	819,000,224	224	0.0000274
100 %		+ 30	818,999,979	-21	-0.0000026
100 %		+ 40	819,000,073	73	0.0000089
100 %		+ 50	819,000,008	8	0.0000010
BATT. ENDPOINT	3.45	+ 20	819,000,226	226	0.0000276

Table 7-6. LTE Band 26 Frequency Stability Data (Ch. 26697)

FCC ID: A3LSMA530N		MEASUREMENT REPORT (CERTIFICATION)	SUNG	Approved by: Quality Manager	
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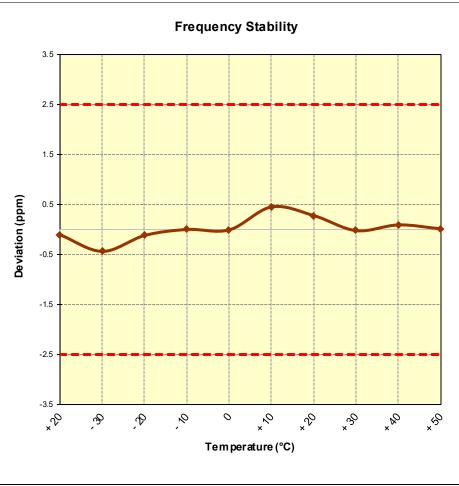


Table 7-7. LTE Band 26 Frequency Stability Data (Ch. 26697)

FCC ID: A3LSMA530N		MEASUREMENT REPORT (CERTIFICATION)	Approved by: Quality Manager
Test Report S/N:	Test Dates:	EUT Type:	Dage 24 of 25
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8.0 CONCLUSION

The data collected relate only to the item(s) tested and show that the **Samsung Portable Handset FCC ID: A3LSMA530N** complies with all the requirements of Parts 22(H) and 90 of the FCC rules.

FCC ID: A3LSMA530N		MEASUREMENT REPORT (CERTIFICATION)	SAMSUNG	Approved by: Quality Manager	
Test Report S/N:	Test Dates:	EUT Type:		Dege 25 of 25	
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